Notice of References Cited Application/Control No. 10/574,736 Examiner MARCOS BATISTA Applicant(s)/Patent Under Reexamination DOI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0036475 A1	02-2005	Nishiyama et al.	370/347
*	В	US-2005/0249173 A1	11-2005	Salokannel et al.	370/338
*	C	US-2005/0259754 A1	11-2005	Ho et al.	375/240.28
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.